

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

PRODUCT SPECIFICATION

規格書

CUSTOMER :

(客戶):志盛翔

DATE :

(日期):2018-08-23

CATEGORY (品名) DESCRIPTION (型	 : ALUMINUM ELECTROLYTIC CAPACITORS : GY 25V100μF(φ6.3X11) 	
号)		
VERSION (版本)	: 01	
Customer P/N	:	
SUPPLIER	:	

SUPPLIER								
PREPARED (拟定)	CHECKED (审核)							
杜焕	刘渭清							

CUSTOMER							
APPROVAL	SIGNATURE						
(批准)	(签名)						

ELECTROLYTIC CAPACITOR SPECIFICATION GY SERIES

		SPECIFICAT	ALTERNATION HISTORY RECORDS				
		GY SERIE					
Rev.	Date	Mark	Page	Contents	Purpose	Drafter	Approver

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	MAN YUE ELECTRONICSELECTROLYTICCOMPANY LIMITEDCAPACITORGY SERIES								S	AMX	ON			
Tab	le 1 Product Dimen Safety vent for≥Φ6.3	sions a	and Ch	aracteristic	28						Unit: m	ım		
Safety vent for $\geq \Phi 6.3$ \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow									ubber					
N o.	SAMXON Part No.	WV (Vdc)	Cap. (µF)	Cap. tolerance	Temp. range(℃)	tanδ (120Hz, 20℃)	Leakage Current (µA,2min)	Max Ripple Current at 105°C 100KHz (mA rms)	Impedance at 25°C 100kHz (Ωmax)	Load lifetime (Hrs)		mensio (mm) F	n 	Sleev e
1	EGY107M1EE11RR**P-R	25	100	-20%~+20%	-40~105	0.14	25	210	0.40	8000	6.3X11	2.5	0.5	PET

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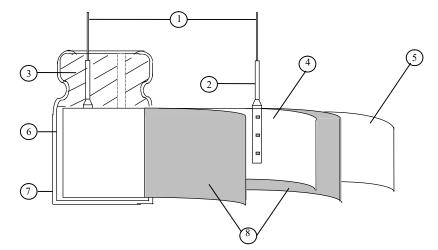
1.	. Application												
1.	This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment.												
	Designed capacitor's quality meets IEC60384.												
2					SILC	50584.							
2.	_	t Numb			-		r						
	12	3 4	56	5 7]	89	Ľ	10 11 12	131	14	1516	17	
	EG	S 1	0 5	5 M		1 H		D 1 1	T (C	SA	Ρ	
12	SERIES	CAP	ACITAN	CE TOL		VOLTAGE		CASE SIZE	TYP		SAMXON SAMXON	SLEEVE	
				I								Ľ	
	Series	Cap(MFD)	Code	Tolerance (%)	Code	Voltage (W.V.)	Code	Case Size	Feature (Code	SAMXON Product L	ine	
	ESM EKF	0.1	104	±5	J	2	0D 0E	Diameter(Radial bulk	RR	For internal use only	·	
	ESS EKS	0.22	224			4	0G	3.5 1 4 C	Ammo Tap	ina	(The product lines we have H,A,B,C,D,		
	EGS EKM	0.22		±10	к	6.3 8	0J OK	3 B 3.5 1 4 C 5 D 6.3 E 8 F 10 G		_	E,M or 0,1,2,3,4,5,9).	
	EKG EOM	0.33	334			10	1A	8 F 10 G	2.0mm Pitch	Π			
	EZM EZS	0.47	474	±15	L	12.5	1B	12.5 I 13 J 13.5 V	2.5mm Pitch	тυ			
	EGF ESF	1	105	±20	м	16 20	1C 1D	13.5 V 14 4 14.5 A	3.5mm Pitch	тν	Sleeve Material	Code	
	EGT EGK	<u> </u>	100			25	1E	14.5 A 16 K 16.5 7					
	EGE	2.2	225	±30	N	30 32	1I 13	18 L 185 8	5.0mm Pitch	тс	PET	P	
	EGC	3.3	335	-40 0	w	35	1V	20 M	Lead Cut &	Form			
	ERF	4.7	475			40	1G 1M	14 4 14.5 A 16 K 16.5 7 18 L 18.5 8 20 M 22 N 25 O 30 P 34 W 35 Q 40 R 42 4 45 6 51 S 63.5 T 76 U 80 8 80 8 90 X 100 Z	СВ-Туре	СВ			
	ERR	4./	4/5	-20 0	Α	50	1H	34 W 35 Q	OF THE	OF			
	ERE	10	106	-20 +10	с	57 63	1L 1J	40 R 42 4	СЕ-Туре	CE			
	ERH EBD	22	226	+10		71	1S	45 6 51 S	HE-Type	HE			
	ERA ERB	33	336	-20 +40	×	75 80	1T 1K	63.5 T 76 U	KD-Type	КD			
	ERC EFA ENP		330		_	85	1R	80 8 90 X 100 Z	FD-Type	FD			
	ENH	47	476	-20 +50	S	90 100	19 2A	Len.(mm) Code	PD-Type				
	ERW	100	107	-10 0	в	120	20	4.5 45 5 05	EH-Type	EH			
	ELP EAP EQP	220	227			125	2B	5.4 54 7 07	PCB Term	nial			
	EDP	220	221	-10 +20	V	150 160	2Z 2C	7.7 77 10.2 T2		sw			
	EHP	330	337	-10 +30	Q	180	2P	11 11 11.5 1A		500			
	EKP	470	477	-10 +50	т	200	2D 22	12 12 12.5 1B	Snap-in	sx			
	EFP ESP	2200	228			220	2N	13 13 13.5 1C		sz			
	EVP			-5 +10	E	230 250	23 2E	20 20 25 25 29.5 2J	Lug	SG			
	EWR	22000	229	-5 +15	F	275	2T	30 30					
	EWT	33000	339			300 310	21 2R	31.5 3A 35 35 35.5 3E		05			
	EWF	47000	479	-5 +20	G	315	2F	50 50 80 80		06			
	EWH			0 +20	R	330 350	2U 2V	100 1L 105 1K		т5			
	EWB VSS	100000	10T	0 +30	0	360	2X	110 1M 120 1N	Screw	Te			
	VNS VKS	150000	15T	+30		375 385	2Q 2Y	120 1N 130 1P 140 1Q		т6			
	VKM VRL	220000	22T	+50	- 1	400	2G	150 1R 155 1E		D5			
	VNH VZS			+5 +15	z	420	2M 2W	160 1S 165 1F		D6			
	VRF	330000	33T	+5 +20	D	500	2H	170 1T 180 1U					
		1000000	10M	+10	~	550 600	25 26	190 1V 200 2L					
		1500000	15M	+50	Y	630	20 2J	215 2A 210 2M					
		0000000		+10 +30	н			130 1P 140 10 150 1R 155 1E 160 18 165 1F 170 1T 180 1U 190 1V 200 2L 215 2A 210 2M 240 2Q 250 2R 260 2S 270 2T					
		2200000	22M					250 2R 260 2S					
		3300000	33M					270 [2]					
8													Ē.
													Τ

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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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	ITEM				PERFO	RMANC	E			
	Rated voltage									
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100
4.1		SV (V.DC)	8	13	20	32	44	63	79	125
	Surge voltage (SV)							•		
4.2	Nominal capacitance (Tolerance)	Condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria>	requency oltage emperat	: N ure : 20	0 Hz \pm 12 ot more t $)\pm$ 2°C apacitanc	han 0.5V				
4.3	Leakage current	<condition> Connecting t minutes, and <criteria> Refer to Table</criteria></condition>	he capao then, me				istor (1	kΩ±10	Ω) in so	eries for 2
4.4	tan δ	<condition> See 4.2, Norr <criteria> Refer to Table</criteria></condition>	n Capac	itance, fo	or measur	ing frequ	ency, vo	oltage and	l tempera	ture.
4.5	Terminal strength	0.5r	ength of capacitor rength of pacitor, 2~3 seco er of lea nm and l	r, applied f Termina applied f onds, and d wire less	force to uls. Force to b then ben Tense	ent the te t it for 9 (kgf) (0.51)	rminal (0° to its	l~4 mm f original j Bending (kş 2.5 (l	from the position v force N gf) 0.25)	rubber) for
		<criteri< td=""><td></td><td></td><td></td><td>0 (1.0) und, no b</td><td>reakage</td><td>5 (0 or loosen</td><td></td><td>terminal.</td></criteri<>				0 (1.0) und, no b	reakage	5 (0 or loosen		terminal.

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ELECTROLYTIC CAPACITOR SPECIFICATION GY SERIES

		<condition< th=""><th></th><th></th><th></th><th>1</th><th></th><th>T.'</th><th></th><th>1</th><th></th></condition<>				1		T .'		1	
		STE	P Testu		rature(°C)			Time			
		1		20±2		_		thermal of	•		
		2		-40(-25)				thermal of	-		
		3		20 ± 2				thermal of	-		
		4		105 ± 2		_		thermal o	•		
		5		20 ± 2	2	Time	to reach	thermal o	equilibr	ium	
		<criteria></criteria>									
		a. $\tan \delta \sinh$				4.4The le	akage cu	irrent me	easured	shall no	t
	Temperature	more than 8		1			4 4751	1 1		1 11	
	characteristi	b. In step 5 more than t			in the lim	it of Iten	n 4.41 ne	leakage	current	shall n	ot
4.6	cs	c. At-40℃	-		(\mathbf{z}) ratio s	hall not e	wood th		of the fo	llowing	
		table.	(-25 C), II	inpedance	(2) 1410 8		xceeu iii	e value (JI IIIC IC	nowing	,
		Working Vo	ltage (V)	6.3	10	16	25	35	50	63	
		Z-25°C/Z		4	3	2	23	2	2	2	
		Z-40°C/Z		8	6	4	3	3	3	3	
		Z-40 C/Z	1200	0	0	т	5	5	5	5	
		Working Vo	ltage (V)	100							
		Z-25°C/Z-	+20℃	2							
		Z-40°C/Z-	+20℃	3							
		For capacita	nce value	> 1000 µ]	F, Add 0.5	per anot	ther 1000)µF for	Z-25/Z-	+20℃,	
				For capacitance value > 1000 μ F, Add 0.5 per another 1000 μ F for Z-25/Z+20°C, Add 1.0 per another 1000 μ F for Z-40°C/Z+20°C							
					Add 1.0	per anot	her 1000	μF for Z	Z-40℃/	Z+20℃	•
		Capacitance,	$\tan \delta$, and	d impedan		-			Z-40℃/	Z+20℃	•
		-		d impedan		-			Z-40℃/	Z+20℃	·
		<condition< td=""><td>></td><td></td><td>nce shall be</td><td>e measure</td><td>ed at 120</td><td>Hz.</td><td></td><td></td><td></td></condition<>	>		nce shall be	e measure	ed at 120	Hz.			
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		<condition< td=""><td>> o IEC6038 with DC bi</td><td>34-4No.4.1 as voltage</td><td>nce shall be 13 method e plus the r</td><td>s, The ca</td><td>ed at 120 pacitor is le curren</td><td>Hz. s stored a t for Tab</td><td>nt a temp ble 1. (7</td><td>perature The sum</td><td>0</td></condition<>	> o IEC6038 with DC bi	34-4No.4.1 as voltage	nce shall be 13 method e plus the r	s, The ca	ed at 120 pacitor is le curren	Hz. s stored a t for Tab	nt a temp ble 1. (7	perature The sum	0
		Condition According t 105°C ±2 v DC and rip product show	> o IEC6038 with DC bi ple peak y uld be testo	34-4No.4.1 as voltage voltage sh ed after 16	13 method plus the r nall not ex 6 hours rec	s, The ca ated ripp ceed the	ed at 120 pacitor is le curren	Hz. s stored a t for Tab yorking v	nt a temp ble 1. (7 voltage)	perature The sum Then t	o o the
	Load	Condition According t 105°C ±2 x DC and rip product show result should	> o IEC6038 with DC bi ple peak uld be testo d meet the	34-4No.4.1 as voltage voltage sh ed after 16	13 method plus the r nall not ex 6 hours rec	s, The ca ated ripp ceed the	ed at 120 pacitor is le curren	Hz. s stored a t for Tab yorking v	nt a temp ble 1. (7 voltage)	perature The sum Then t	o o the
4.7	Load life	Condition According t 105°C ±2 x DC and rip product show result should <criteria></criteria>	> o IEC6038 with DC bi ple peak uld be teste d meet the	34-4No.4.1 as voltage voltage sh ed after 16 following	13 method 13 method e plus the r nall not ex 6 hours rec g table:	s, The ca ated ripp ceed the overing t	pacitor is pacitor is le curren rated w ime at at	Hz. s stored a t for Tab yorking v	nt a temp ble 1. (7 voltage)	perature The sum Then t	o o the
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		<criteria></criteria>	
		The characteristic shall meet th	
		Leakage current	Value in 4.3 shall be satisfied
1.0	Shelf	Capacitance Change	Within $\pm 25\%$ of initial value.
4.8	life	tan δ	Not more than 200% of the specified value.
	test	Appearance	There shall be no leakage of electrolyte.
		Remark: If the capacitors are st	tored more than 1 year, the leakage current may
		increase. Please apply voltage t	through about 1 k Ω resistor, if necessary.
		<condition></condition>	
		Applied a surge voltage to the	capacitor connected with a $(100 \pm 50)/C_R$ (k Ω) resistor.
			ed to 1000 cycles, each consisting of charge of $30 \pm 5s$,
		followed discharge of 5 min 30	
		The test temperature shall be	
		C_{R} :Nominal Capacitance (μ	F)
	Surge	<criteria></criteria>	Not more than the manified value
4.9	test	Leakage current	Not more than the specified value.
		Capacitance Change	Within $\pm 15\%$ of initial value.
		tan δ	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	a at almomptal attraction only. It is not annihood la to such
		over voltage as often applied.	e at abnormal situation only. It is not applicable to such
		over voltage as orten applied.	
4.10	Vibration test	perpendicular directions. Vibration frequency rang Peak to peak amplitude Sweep rate Mounting method:	
		Appearance of	To be soldered ems shall be tested: o intermittent contacts, open or short circuiting. o damage of tab terminals or electrodes. o mechanical damage in terminal. No leakage celectrolyte or swelling of the case. he markings shall be legible.

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]
		<condition></condition>			
		The capacitor shall be tested un	der the following c : 245±3°C	conditions:	
		Soldering temperature			
	Saldarahilita	Dipping depth	: 2mm	1	
4.11	Solderability test	Dipping speed	: 25±2.5mm	/S	
	iest	Dipping time <criteria></criteria>	: 3±0.5s		
			A minimum	of 95% of the surface be	eina
		Coating quality	immersed		
		<condition></condition>			
		Terminals of the capacitor shall			
		1 seconds or 400 \pm 10 °C for 3 $^{+1}_{-0}$ s	seconds to 1.5~2.0r	nm from the body of cap	bacitor .
		Then the capacitor shall be left	under the normal t	emperature and normal h	numidity
	Resistance to	for 1~2 hours before measurem	ent.		
4.12	solder heat	<criteria></criteria>			_
	test	Leakage current	Not more than the	ne specified value.	
		Capacitance Change	Within $\pm 10\%$ o	f initial value.	
		$\tan \delta$	Not more than the	ne specified value.	
Í		Appearance	There shall be no	o leakage of electrolyte.	
				6 5	
		<condition></condition>			
		Temperature Cycle:According			all be
		placed in an oven, the condition	-	w: Time	
		Temper	ature		
		(1)+20°C		≤3 Minutes	
	Change of	(2)Rated low temperature	(-40°C) (-25°C)	30 ± 2 Minutes	
4.13	temperature	(3)Rated high temperature	(+105℃)	30 ± 2 Minutes	
	test	(1) to (3)=1 cycle, total 5 c	ycle		
		<criteria></criteria>	-		
		The characteristic shall meet th	e following require	ement	
		Leakage current N	lot more than the s	pecified value.	
		tan δ N	ot more than the s	pecified value.	
		Appearance T	here shall be no lea	akage of electrolyte.	
		<condition></condition>			
		Humidity Test:			
		According to IEC60384-4No.4	-	-	
		hours in an atmosphere of 90~9		C, the characteristic char	nge shall
		meet the following requirement	•		
		< <u>Criteria></u>		· (* 1 1	
4.14	Damp heat	,	more than the spec		
	test	1 0	$\frac{1}{120\%}$ of initial		
				f the specified value.	
		Appearance The	re shall be no leaka	ge of electrolyte.	

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4.15	Vent test	<condition> The following test only apply to those products with vent products at diameter $\ge \emptyset 6.3$ with vent. D.C. test The capacitor is connected with its polarity reversed to a DC power source. Then a current selected from below table is applied. <table 3=""> $\overrightarrow{Diameter (mm)}$ $\overrightarrow{DC Current (A)}$ 22.4 or less 1 $\overrightarrow{Over 22.4}$ 10 Criteria> The vent shall operate with no dangerous conditions such as flames or dispersion of pieces of the capacitor and/or case.</table></condition>
4.16	Maximum permissible (ripple current)	Condition> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exceed the rated voltage and shall not reverse voltage. Frequency Multipliers: Coefficient Freq. Coefficient (Hz) 120 1k 10k 100k 100k

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SAMXON

5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances			
Heavy metals	Cadmium and cadmium compounds			
	Lead and lead compounds			
	Mercury and mercury compounds			
	Hexavalent chromium compounds			
	Polychlorinated biphenyls (PCB)			
Chloinated	Polychlorinated naphthalenes (PCN)			
organic	Polychlorinated terphenyls (PCT)			
compounds	Short-chain chlorinated paraffins(SCCP)			
	Other chlorinated organic compounds			
	Polybrominated biphenyls (PBB)			
Brominated organic compounds	Polybrominated diphenylethers(PBDE) (including			
	decabromodiphenyl ether[DecaBDE])			
	Other brominated organic compounds			
Tributyltin comp	bounds(TBT)			
Triphenyltin con	npounds(TPT)			
Asbestos				
Specific azo com	pounds			
Formaldehyde				
Beryllium oxide				
Beryllium copp	er			
Specific phthalat	tes (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)			
Hydrofluorocarb	oon (HFC), Perfluorocarbon (PFC)			
Perfluorooctane	sulfonates (PFOS)			
Specific Benzotr	iazole			

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Attachment: Application Guidelines

1.Circuit Design

(2)

- 1.1 Operating Temperature and Frequency
- Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- Effects of operating temperature on electrical parameters
 At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
 - Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while $\tan \delta$ increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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(6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification. 1.6 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths. 1.7 The Product endurance should take the sample as the standard. 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling. 1.9 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures. CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure. **2.**Capacitor Handling Techniques 2.1 Considerations Before Using (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about $1k\Omega$. (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately $1k\Omega$. (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result. 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection. 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve. 2.4 Flow Soldering (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result. (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits. (3) Do not allow other parts or components to touch the capacitor during soldering.

2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning
- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
- Acetone : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the

circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.

- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.
- 2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

- 3.1 Environmental Conditions
 - Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause

the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000Ω , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions



The capacitor shall be not use in the following condition:

(1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.

(2) Direct contact with water, salt water, or oil.

(3) High humidity conditions where water could condense on the capacitor.

(4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.

(5) Exposure to ozone, radiation, or ultraviolet rays.

(6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

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